# onsemi

### Silicon Carbide (SiC) MOSFET – 80 mohm, 1200 V, M1, D2PAK-7L

## NVBG080N120SC1

#### Features

- Typ.  $R_{DS(on)} = 80 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ.  $Q_{G(tot)} = 56 \text{ nC}$ )
- Low Effective Output Capacitance (Typ. Coss = 79 pF)
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

#### **Typical Applications**

- Automotive On Board Charger
- Automotive DC-DC Converter for EV/HEV

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

| Para  | Symbol          | Value                  | Unit                              |                |    |
|---|-----------------|------------------------|-----------------------------------|----------------|----|
| Drain-to-Source Voltage   |                 |                        | V <sub>DSS</sub>                  | 1200           | V  |
| Gate-to-Source Voltag   | ge              |                        | V <sub>GS</sub>                   | -15/+25        | V  |
| Recommended Operate<br>Values of Gate-Source  |                 | T <sub>C</sub> < 175°C | V <sub>GSop</sub>                 | -5/+20         | V  |
| Continuous Drain<br>Current (Note 1)  | Steady<br>State | $T_C = 25^{\circ}C$    | ۱ <sub>D</sub>                    | 30             | A  |
| Power Dissipation (Note 1)  |                 |                        | PD                                | 179            | W  |
| Continuous Drain<br>Current (Note 1)  | Steady<br>State | T <sub>C</sub> = 100°C | ۱ <sub>D</sub>                    | 21             | A  |
| Power Dissipation (Note 1)  |                 |                        | PD                                | 89             | W  |
| Pulsed Drain Current (Note 2) $T_{C} = 25^{\circ}C$   |                 |                        | I <sub>DM</sub>                   | 110            | А  |
| $ \begin{array}{ll} \mbox{Single Pulse Surge} \\ \mbox{Drain Current} \\ \mbox{Capability} \end{array} & T_C = 25^\circ C, \ t_p = 10 \ \mu s, \\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ $ |                 | I <sub>DSC</sub>       | 132                               | A              |    |
| Operating Junction and Storage Temperature Range  |                 |                        | T <sub>J</sub> , T <sub>stg</sub> | –55 to<br>+175 | °C |
| Source Current (Body Diode)   |                 |                        | ۱ <sub>S</sub>                    | 18             | А  |
| Single Pulse Drain-to-Source Avalanche<br>Energy (I <sub>L</sub> = 18.5 A <sub>pk</sub> , L = 1 mH) (Note 3)  |                 |                        | E <sub>AS</sub>                   | 171            | mJ |
| Maximum Lead Temperature for Soldering, 1/8" from Case for 10 Seconds   |                 |                        | ΤL                                | 300            | °C |

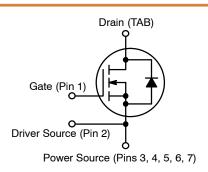
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Repetitive rating, limited by max junction temperature.

3. E<sub>AS</sub> of 171 mJ is based on starting T<sub>J</sub> = 25°C; L = 1 mH, I<sub>AS</sub> = 18.5 A, V<sub>DD</sub> = 120 V, V<sub>GS</sub> = 18 V.

| V <sub>(BR)DSS</sub> | R <sub>DS(ON)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| 1200 V               | 110 m $\Omega$ @ 20 V   | 30 A               |



#### N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

#### MARKING DIAGRAM



= Assembly Location

Y = Year

A

- WW = Work Week
- ZZ = Lot Traceability

NVBG080120SC1 = Specific Device Code

#### **ORDERING INFORMATION**

| Device         | Package  | Shipping <sup>†</sup> |
|----------------|----------|-----------------------|
| NVBG080N120SC1 | D2PAK-7L | 800 /<br>Tape & Reel  |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, <u>BRD8011/D</u>.

#### Table 1. THERMAL CHARACTERISTICS

| Parameter                                       | Symbol                | Мах  | Unit |
|---|-----------------------|------|------|
| Thermal Resistance Junction-to-Case (Note 1)    | $R_{	extsf{	heta}JC}$ | 0.84 | °C/W |
| Thermal Resistance Junction-to-Ambient (Note 1) | $R_{\theta JA}$       | 40   | °C/W |

#### Table 2. ELECTRICAL CHARACTERISTICS (T<sub>1</sub> = 25°C unless otherwise stated)

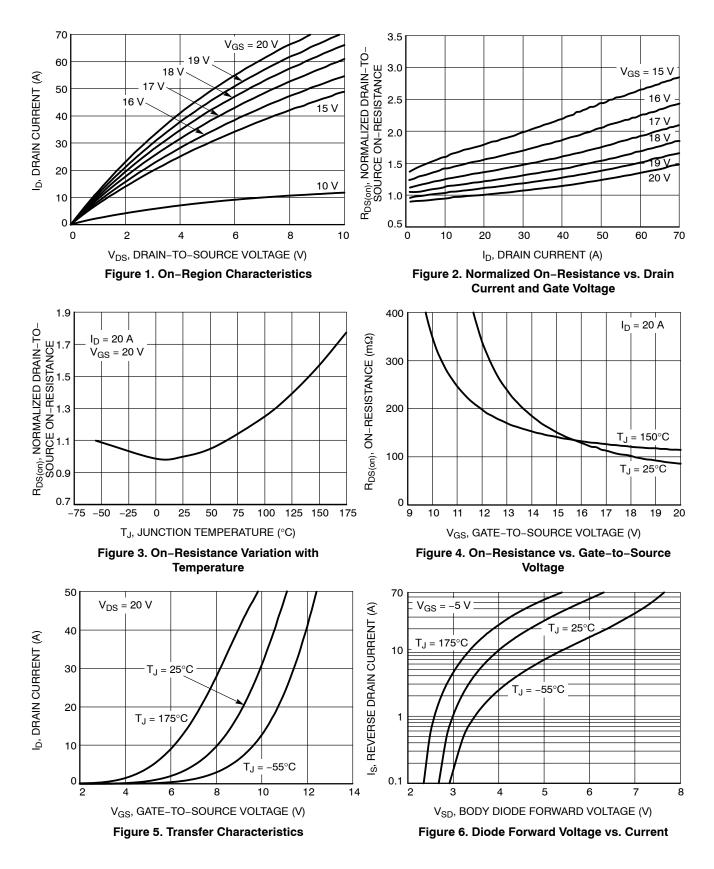
| Parameter  | Symbol                               | Test Condition  |                               | Min  | Тур  | Max | Unit |
|--|--------------------------------------|---|-------------------------------|------|------|-----|------|
| OFF CHARACTERISTICS  | •                                    | -   |                               |      |      |     |      |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                 | $V_{GS} = 0 V, I_D = 1$   | mA                            | 1200 |      |     | V    |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /T <sub>J</sub> | I <sub>D</sub> = 1 mA, refer t  | o 25°C                        |      | 0.5  |     | V/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                     | V <sub>GS</sub> = 0 V,  | $T_J = 25^{\circ}C$           |      |      | 100 | μA   |
|  |                                      | V <sub>DS</sub> = 1200 V  | T <sub>J</sub> = 175°C        |      |      | 1   | mA   |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                     | V <sub>GS</sub> = +25/-15 V   | , V <sub>DS</sub> = 0 V       |      |      | ±1  | μA   |
| ON CHARACTERISTICS (Note 2)                                  |                                      |   |                               | •    |      |     |      |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                  | $V_{GS} = V_{DS}, I_D = 8$  | 5 mA                          | 1.8  | 3    | 4.3 | V    |
| Recommended Gate Voltage                                     | V <sub>GOP</sub>                     |   |                               | -5   |      | +20 | V    |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                  | $V_{GS} = 20 \text{ V}, \text{ I}_{D} = 20 \text{ V}$                       | 20 A, T <sub>J</sub> = 25°C   |      | 80   | 110 | mΩ   |
|  |                                      | $V_{GS} = 20 \text{ V}, \text{ I}_{D} = 20 \text{ V}$                       | 20 A, T <sub>J</sub> = 150°C  |      | 121  |     | mΩ   |
| Forward Transconductance                                     | 9FS                                  | V <sub>DS</sub> = 20 V, I <sub>D</sub> = 2                                  | 20 A                          |      | 11   |     | S    |
| CHARGES, CAPACITANCES & GATE RES                             | ISTANCE                              |   |                               |      |      |     |      |
| Input Capacitance  | C <sub>ISS</sub>                     | V <sub>GS</sub> = 0 V, f = 1 MHz,<br>V <sub>DS</sub> = 800 V                |                               |      | 1154 |     | pF   |
| Output Capacitance   | C <sub>OSS</sub>                     |   |                               |      | 79   |     |      |
| Reverse Transfer Capacitance                                 | C <sub>RSS</sub>                     |   |                               |      | 7.9  |     |      |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                  | $V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V},$<br>$I_D = 20 \text{ A}$ |                               |      | 56   |     | nC   |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                   |   |                               |      | 10   |     |      |
| Gate-to-Source Charge  | Q <sub>GS</sub>                      |   |                               |      | 18   |     |      |
| Gate-to-Drain Charge   | Q <sub>GD</sub>                      |   |                               |      | 11   |     |      |
| Gate-Resistance  | R <sub>G</sub>                       | f = 1 MHz   |                               |      | 1.2  |     | Ω    |
| SWITCHING CHARACTERISTICS                                    |                                      |   |                               |      |      |     |      |
| Turn-On Delay Time   | t <sub>d(ON)</sub>                   | $V_{GS} = -5/20$ V, V   | / <sub>DS</sub> = 800 V,      |      | 12   | 22  | ns   |
| Rise Time  | t <sub>r</sub>                       | I <sub>D</sub> = 20 A, R <sub>G</sub> = 4<br>Inductive Load                 | 4.7 Ω,                        |      | 12   | 22  |      |
| Turn-Off Delay Time  | t <sub>d(OFF)</sub>                  |   |                               |      | 21   | 34  |      |
| Fall Time  | t <sub>f</sub>                       |   |                               |      | 9    | 18  |      |
| Turn-On Switching Loss                                       | E <sub>ON</sub>                      |   |                               |      | 135  |     | μJ   |
| Turn-Off Switching Loss                                      | E <sub>OFF</sub>                     |   |                               |      | 46   |     |      |
| Total Switching Loss   | E <sub>TOT</sub>                     |   |                               |      | 181  |     |      |
| DRAIN-SOURCE DIODE CHARACTERIST                              | ICS                                  | -   |                               | -    | -    |     | -    |
| Continuous Drain-Source Diode Forward<br>Current             | I <sub>SD</sub>                      | $V_{GS}$ = -5 V, T <sub>J</sub> =   | 25°C                          |      |      | 18  | A    |
| Pulsed Drain-Source Diode Forward<br>Current (Note 2)        | I <sub>SDM</sub>                     | V <sub>GS</sub> = -5 V, T <sub>J</sub> =                                    | 25°C                          |      |      | 110 | A    |
| Forward Diode Voltage  | V <sub>SD</sub>                      | V <sub>GS</sub> = -5 V, I <sub>SD</sub> =                                   | = 10 A, T <sub>J</sub> = 25°C | İ    | 3.9  |     | V    |

#### Table 2. ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated) (continued)

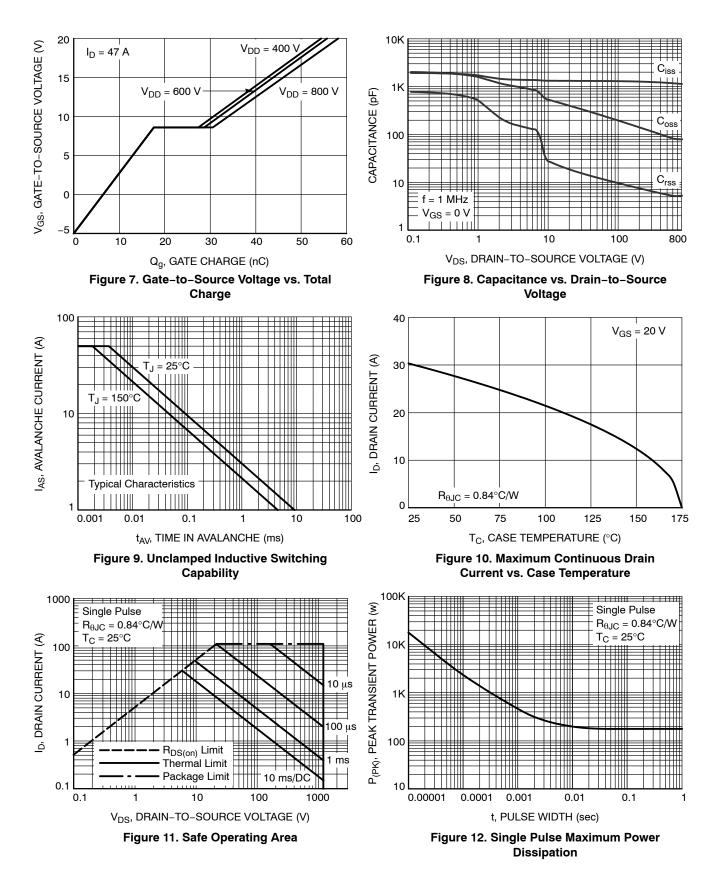
| Parameter                          | Symbol           | Test Condition  | Min | Тур  | Max | Unit |  |  |
|------------------------------------|------------------|---|-----|------|-----|------|--|--|
| DRAIN-SOURCE DIODE CHARACTERISTICS |                  |   |     |      |     |      |  |  |
| Reverse Recovery Time              | t <sub>RR</sub>  | V <sub>GS</sub> = -5/20 V, I <sub>SD</sub> = 20 A,<br>dI <sub>S</sub> /dt = 1000 A/μs |     | 16.2 |     | ns   |  |  |
| Reverse Recovery Charge            | Q <sub>RR</sub>  | $di_{S}/dt = 1000 A/\mu s$  |     | 61.6 |     | nC   |  |  |
| Reverse Recovery Energy            | E <sub>REC</sub> |   |     | 4.1  |     | μJ   |  |  |
| Peak Reverse Recovery Current      | I <sub>RRM</sub> |   |     | 7.6  |     | А    |  |  |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**



#### TYPICAL CHARACTERISTICS (continued)



#### TYPICAL CHARACTERISTICS (continued)

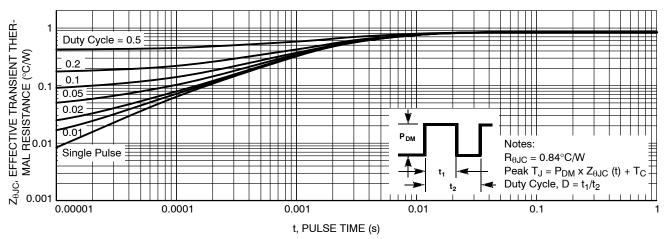
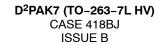


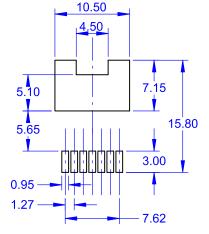
Figure 13. Junction-to-Case Transient Thermal Response Curve

DATE 16 AUG 2019

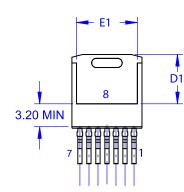




Α F L1 D b2 е h  $\oplus$ aaa B A M



LAND PATTERN RECOMMENDATION



Г

GENERIC **MARKING DIAGRAM\*** 

| XXXXXXXXX<br>AYWWG |
|--------------------|
| 0                  |

XXXX = Specific Device Code А = Assembly Location Y = Year

- WW = Work Week
- G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

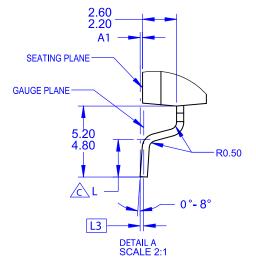
| B    | A |
|------|---|
| c2 — | - |
| •    |   |
|      |   |
| H    |   |
|      |   |
|      |   |
|      | A |

NOTES:

A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

C OUT OF JEDEC STANDARD VALUE. D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009. E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

| DIM | MIL   | MILLIMETERS |       |  |
|-----|-------|-------------|-------|--|
|     | MIN   | NOM         | MAX   |  |
| Α   | 4.30  | 4.50        | 4.70  |  |
| A1  | 0.00  | 0.10        | 0.20  |  |
| b2  | 0.60  | 0.70        | 0.80  |  |
| b   | 0.51  | 0.60        | 0.70  |  |
| С   | 0.40  | 0.50        | 0.60  |  |
| c2  | 1.20  | 1.30        | 1.40  |  |
| D   | 9.00  | 9.20        | 9.40  |  |
| D1  | 6.15  | 6.80        | 7.15  |  |
| E   | 9.70  | 9.90        | 10.20 |  |
| E1  | 7.15  | 7.65        | 8.15  |  |
| е   | ~     | 1.27        | ~     |  |
| Н   | 15.10 | 15.40       | 15.70 |  |
| L   | 2.44  | 2.64        | 2.84  |  |
| L1  | 1.00  | 1.20        | 1.40  |  |
| L3  | ~     | 0.25        | ~     |  |
| aaa | ~     | ~           | 0.25  |  |



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| DESCRIPTION:     | D <sup>2</sup> PAK7 (TO-263-7L HV) |  | PAGE 1 OF 1 |

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